Rev.2.0

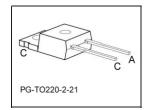
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Fast Switching EmCon Diode Feature

- 1200 V EmCon technology
- Fast recovery
- Soft switching
- Low reverse recovery charge
- Low forward voltage
- Easy paralleling
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC⁽⁰⁾ for target applications

Product	Summary
1104400	Garmary

V _{RRM}	1200	V
/ _F	18	А
V _F	1.65	\vee
T _{jmax}	150	°C



Туре	Package	Marking	Pin 1	PIN 2	
IDH18E120	PG-TO220-2-21	D18E120	С	А	-

Maximum Ratings, at $T_i = 25 \text{ °C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Repetitive peak reverse voltage	V _{RRM}	1200	V
Continous forward current	/ _F		А
T _C =25°C		31	
7 _C =90°C		19.8	
Surge non repetitive forward current	/ _{FSM}	78	
$T_{\rm C}$ =25°C, $t_{\rm p}$ =10 ms, sine halfwave			
Maximum repetitive forward current	/ _{FRM}	47	
$T_{\rm C}$ =25°C, $t_{\rm p}$ limited by $T_{\rm jmax}$, D=0.5			
Power dissipation	P _{tot}		W
T _C =25°C		113	
7 _C =90°C		54	
Operating and storage temperature	T _j , T _{stg}	-55+150	°C
Soldering temperature wavesoldering, 1.6mm (0.063 in.) from case for 10s	T _S	260	°C

⁰ J-STD20 and JESD22





Thermal Characteristics

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R _{thJC}	-	-	1.1	K/W
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	62	

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
Static Characteristics					
Reverse leakage current	/ _R				μA
V _R =1200V, <i>T</i> _j =25°C		-	-	100	
V _R =1200V, <i>T</i> _j =150°C		-	-	1400	
Forward voltage drop	V _F				V
/ _F =18Α, <i>Τ</i> _j =25°C		-	1.65	2.15	
I _F =18A, <i>T</i> j=25°C I _F =18A, <i>T</i> j=150°C		_	1.7	-	

Electrical Characteristics, at T_i = 25 °C, unless otherwise specified

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

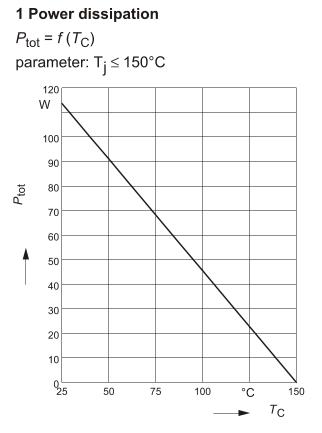


Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics	·				
Reverse recovery time	t _{rr}				ns
V _R =800V, <i>I</i> _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =25°C		-	195	-	
V _R =800V, / _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, 7 _j =125°C		-	280	-	
V _R =800V, / _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, Τ _j =150°C		-	300	-	
Peak reverse current	/ _{rrm}				А
V _R =800V, <i>I</i> _F = 18 A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =25°C		-	20.2	-	
V _R =800V, <i>I</i> _F =18A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =125°C		-	24.4	-	
V _R =800V, <i>I</i> _F =18A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =150°C		-	25.3	-	
Reverse recovery charge	Q _{rr}				nC
V _R =800V, <i>I</i> _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =25°C		-	1880	-	
$V_{\rm R}$ =800V, $I_{\rm F}$ =18A, $di_{\rm F}/dt$ =800A/µs, $T_{\rm j}$ =125°C		-	3200	-	
$V_{\rm R}$ =800V, $I_{\rm F}$ =18A, $di_{\rm F}/dt$ =800A/µs, $T_{\rm j}$ =150°C		-	3540	-	
Reverse recovery softness factor	S				
V _R =800V, / _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, 7 _j =25°C		-	5.5	-	
V _R =800V, <i>I</i> _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =125°C		-	6.6	-	
V _R =800V, I _F =18A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _i =150°C		-	6.7	-	

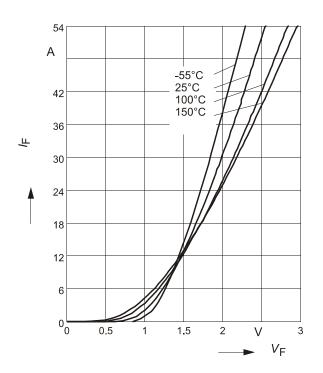
Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified



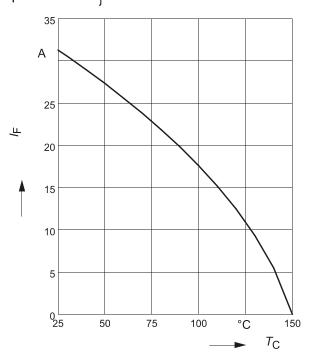
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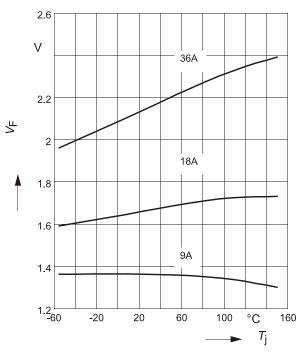




2 Diode forward current $I_{\rm F} = f(T_{\rm C})$ parameter: $T_{\rm i} \le 150^{\circ}{\rm C}$



4 Typ. diode forward voltage $V_{\mathsf{F}} = f(T_{\mathsf{j}})$



2007-02-26



5 Typ. reverse recovery time

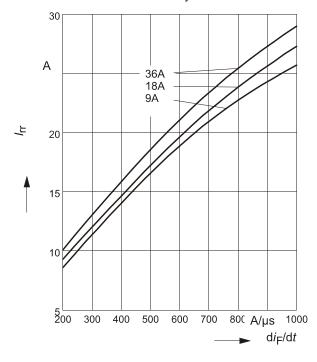
 $t_{\rm rr} = f \left({\rm d}i_{\rm F}/{\rm d}t \right)$

parameter: V_R = 800V, T_i = 125°C 1000 ns 800 36A 18A 700 9A tr 600 500 400 300 200 100 300 400 500 600 700 80C A/µs 1000 di_F/dt

7 Typ. reverse recovery current

 $I_{\rm rr} = f \left({\rm d}i_{\rm F} / {\rm d}t \right)$

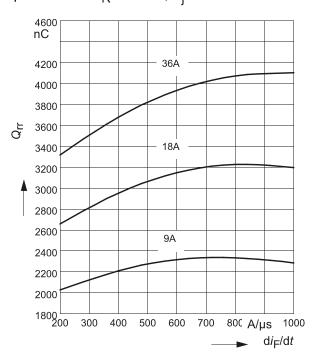
parameter: V_R = 800V, T_i = 125°C



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6 Typ. reverse recovery charge Q_{rr}=f(d*i*_F/d*t*)

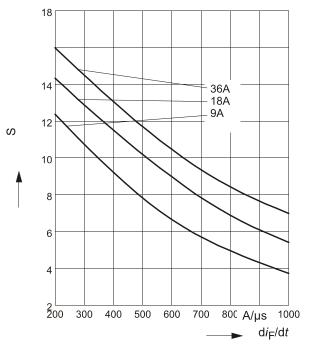
parameter: $V_{\rm R}$ = 800V, $T_{\rm i}$ = 125 °C



8 Typ. reverse recovery softness factor

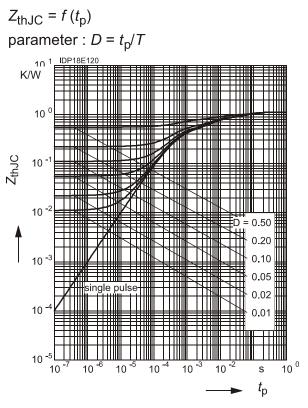
 $S = f(di_F/dt)$

parameter: V_R = 800V, T_i = 125°C



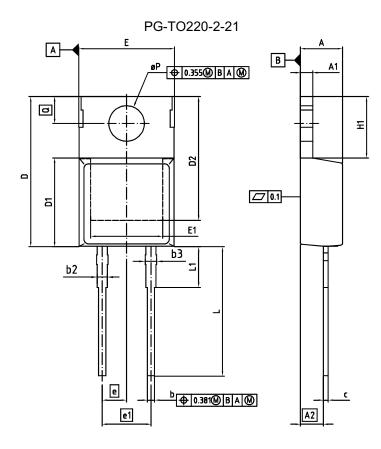


9 Max. transient thermal impedance



IDH18E120





	dimensions			
symbol	[mm]		[mm] [in	
· · · ·	min	max	min	max
А	4.191	4.699	0.165	0.185
A1	1.219	1.321	0.048	0.052
A2	2.387	2.489	0.094	0.098
b	0.635	0.889	0.025	0.035
b2	1.143	1.397	0.045	0.055
b3	1.143	1.651	0.045	0.065
С	0.331	0.635	0.013	0.025
D	15.113	15.621	0.595	0.615
D1	9.017	9.271	0.355	0.365
D2	13.737	14.245	0.541	0.561
E	9.677	9.931	0.381	0.391
E1	8.28	8.788	0.324	0.346
е	2.	54	0	.1
e1	5.029	5.131	0.198	0.202
H1	6.096	6.35	0.24	0.25
L	12.802	13.31	0.504	0.524
L1	3.048	3.302	0.12	0.13
Р	3.632	3.734	0.143	0.147
Q	2.54	3.048	0.1	0.12



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